



FCC&IC RF Test Report

Product Name: HSDPA Module

Model Number: MU509-c

Report No: SYBH(Z-RF)019032013-2001

Class II Permissive Change of FCC ID: QISMU509C Class II Permissive Change of IC: 6369A-MU509C

Reliability Laboratory of Huawei Technologies Co., Ltd.

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Notice

- 1. The laboratory has Passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
- 2. The laboratory has Passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
- 3. The laboratory has been listed by the US Federal Communications Commission to perform electromagnetic emission measurements. The site recognition number is 97456.
- 4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-2.
- 5. The laboratory has been listed by the VCCI to perform EMC measurements. The accreditation numbers of test site No.1 are R-2364, G-415, C-2583, and T-256, and the accreditation numbers of test site No.2 are R-3760, G-485, C-4210 and T-1237.
- 6. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
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- 8. The test report is only valid for the test samples.
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Applicant: Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

Date of Receipt Sample:2013-03-26Start Date of Test:2013-04-01End Date of Test:2013-04-11

Test Result: Pass

Approved by Senior 2013-04-11 Dai Linjun

Engineer: Date Name Signature

Prepared by: 2013-04-11 Zhu Mingjing

Date Name Signature



Modification Record

No.	Last Report No.	Modification Description
1		First report.



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1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 02:2012

47 CFR FCC Part 22: 2012 47 CFR FCC Part 24: 2012

IC RSS-Gen Issue 3, IC RSS-132 Issue 3, IC RSS-133 Issue 6,

Test Method: FCC KDB 971168 D01 Power Meas License Digital Systems v01

FCC KDB 662911 D01 Multiple Transmitter Output v01r02

1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C

Ambient Relative Humidity: 40 to 55 %

Atmospheric Pressure: Not applicable



2 Test Summary

2.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

Test Item	FCC Rule No.	IC Rule No.	Requirements	Test Result	Verdict (NOTE 2)
Transmit Output	§2.1046,	RSS-Gen, §4.8;	FCC: ERP ≤ 7 W.	Appendix A	Pass
Power Data	§22.913	RSS-132, §4.4	IC: EIRP ≤ 11.5 W.	Appendix A	Pass
Modulation Characteristics	§2.1047	RSS-132, §4.2	Digital modulation	Appendix C	SYBH(Z-RF)001 112012-2001
Bandwidth	§2.1049,	RSS-Gen, §4.6	OBW: No limit.	Appendix	SYBH(Z-RF)001
Danuwium	§22.917	K33-Gen, 94.0	EBW: No limit.	D	112012-2001
Band Edges Compliance	§2.1051, §22.917	RSS-Gen, §4.9; RSS-132, §4.5	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block.	Appendix E	SYBH(Z-RF)001 112012-2001
Spurious Emission at Antenna Terminals	§2.1051, §22.917	RSS-Gen, §4.9; RSS-132, §4.5	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges. IC: ≤ -13 dBm/100 kHz (for EBW ≤ 4 MHz) or ≤ -13 dBm/1 MHz (for EBW > 4 MHz), from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Appendix F	SYBH(Z-RF)001 112012-2001
Field Strength of Spurious Radiation	§2.1053, §22.917	RSS-Gen, §4.9; RSS-132, §4.5	FCC: \leq -13 dBm/100 kHz. IC: \leq -13 dBm/100 kHz (for EBW \leq 4 MHz) or \leq -13 dBm/1 MHz (for EBW > 4 MHz).	Appendix G	Pass
Receiver Spurious Emissions (NOTE 1)		RSS-Gen, §4.10; RSS-Gen, §6; RSS-132, §4.6	Radiated limit: RSS-Gen, §6.1 field strength limit. Conducted limit: ≤ -57 dBm/120 kHz (CISPR-QP), from 30 MHz to 1000 MHz, and ≤ -53 dBm/1 MHz (AV), from 1 GHz to 3 rd harmonics.	Appendix H	Pass
Frequency Stability	§2.1055, §22.355	RSS-Gen, §4.7; RSS-132, §4.3	≤ ±2.5ppm.	Appendix I	SYBH(Z-RF)001 112012-2001

NOTE 1: For Receiver Spurious Emissions, If the receiver has a detachable antenna of known impedance, antenna conducted spurious emissions measurement is permitted as an alternative to radiated measurement. However, the radiated method is recommended. The antenna conducted test shall be performed with the antenna disconnected and the receiver antenna terminals connected to a measuring instrument having equal impedance to that specified for the antenna.

NOTE 2: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".



2.2 PCS Band (1850-1915 MHz paired with 1930-1995 MHz)

Test Item	FCC	IC Rule No.	Requirements	Test Result	Verdict (NOTE 2)
	Rule No.				
Transmit Output	§2.1046,	RSS-Gen, §4.8;	EIRP ≤ 2 W; PAR ≤ 13 dB.	Appendix A	Pass
Power Data	§24.232	RSS-133, §6.4			
Peak-Average	§2.1046, RSS-Gen, §4.8;		Appendix B	SYBH(Z-RF)001	
Ratio	§24.232	RSS-133, §6.4	FCC: Limit≤13 dB	Appendix 6	112012-2002
Modulation	§2.1047	RSS-133, §6.2	Digital modulation	Appendix C	SYBH(Z-RF)001
Characteristics	92.1047	K33-133, g0.2	Digital modulation	Appendix C	112012-2002
Bandwidth	§2.1049,	RSS-Gen, §4.6	OBW: No limit.	Appendix D	SYBH(Z-RF)001
	§22.917		EBW: No limit.	Appendix D	112012-2002
Band Edges	§2.1051,	RSS-Gen, §4.9;	≤ -13 dBm/1%*EBW, in 1 MHz		
Compliance	§24.238	RSS-133, §6.5	bands immediately outside	Appendix E	SYBH(Z-RF)001
			and adjacent to the frequency	Appendix	112012-2002
			block.		
Spurious	§2.1051,	RSS-Gen, §4.9;	≤ -13 dBm/1 MHz, from 9 kHz		
Emission at	§24.238	RSS-133, §6.5	to 10 th harmonics but outside	Appendix F	SYBH(Z-RF)001
Antenna			authorized operating		112012-2002
Terminals			frequency ranges.		
Field Strength of	§2.1053,	RSS-Gen, §4.9;	≤ -13 dBm/1 MHz.		
Spurious	§24.238	RSS-133, §6.5		Appendix G	Pass
Radiation					
Receiver		RSS-Gen,	Radiated limit: RSS-Gen, §6.1		
Spurious		§4.10;	field strength limit.		
Emissions		RSS-Gen, §6;	Conducted limit: ≤ -57		
(NOTE 1)		RSS-133, §6.6	dBm/120 kHz (CISPR-QP),	Appendix H	Pass
			from 30 MHz to 1000 MHz,		
			and ≤ -53 dBm/1 MHz (AV),		
			from 1 GHz to 3 rd harmonics.		
Frequency	§2.1055,	RSS-Gen, §4.7;	FCC: within authorized		SYBH(Z-RF)001
Stability	§24.235	RSS-133, §6.3	frequency block.	Appendix I	112012-2002
			IC: ≤ ±2.5 ppm.		112012 2002

NOTE 1: For Receiver Spurious Emissions, If the receiver has a detachable antenna of known impedance, antenna conducted spurious emissions measurement is permitted as an alternative to radiated measurement. However, the radiated method is recommended. The antenna conducted test shall be performed with the antenna disconnected and the receiver antenna terminals connected to a measuring instrument having equal impedance to that specified for the antenna.

NOTE 2: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".



3 <u>Description of the Equipment under Test (EUT)</u>

3.1 General Description

MU509-c Module is subscriber equipment in the GSM/UMTS system. The frequency bands of this report are GSM850M&GS1900&WCDMA850&WCDMA1900. The MU509-c implements such functions as RF signal receiving / Transmitting, HSDPA/WCDMA/EDGE/GPRS/GSM protocol processing and data service etc. Externally it provides LGA interface. It has not an internal antenna. MU509-c uses Qualcomm QSC6270 chipset and Zero-IF technologies.

3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 Board

Board					
Serial Number Hardware Version Description					
4CA6RB9322100325	Main Board				



3.3 Technical Specification

Characteristics	Description				
Radio System Type	⊠ GSM				
	□ UMTS				
Supported Frequency Range	GSM850/ WCDMA850	Transmission (TX): 824 to 849 MHz			
	GSIVIOSO/ WCDIVIAOSO	Receiving (RX): 869 to 894 MHz			
	GSM1900/ WCDMA1900	Transmission (TX): 1850 to 1910 MHz			
	G3W1900/ WCDWA1900	Receiving (RX): 1930 to 1990 MHz			
TX and RX Antenna Ports	TX & RX port:	1			
	TX-only port:	0			
	RX-only port:	1			
Target TX Output Power	GSM850: 33dBm				
	GSM1900 30dBm				
	UMTS850 23.5dBm				
	UMTS1900: 23.5dBm				
Supported Channel Bandwidth	GSM system:				
	UMTS system:	⊠ 5 MHz			
Designation of Emissions	GSM850:	245KGXW, 245KG7W			
(Note: the necessary bandwidth of	GSM1900:	247KGXW, 246KG7W			
which is the worst value from the	UMTS850:	4M17F9W			
measured occupied bandwidths for	UMTS1900:	4M16F9W			
each type of channel bandwidth					
configuration.)					



4 General Test Conditions / Configurations

4.1 Test Modes

NOTE: The test mode(s) are selected according to relevant radio technology specifications.

Test Mode	Test Modes Description	
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation	
GSM/TM2	GSM system, EDGE, 8PSK modulation	
UMTS/TM1	WCDMA system, QPSK modulation	
UMTS/TM2	HSDPA system, QPSK modulation	

4.2 Test Environment

Environment Parameter	Selected Values During Tests		
Relative Humidity	Ambient		
Temperature	TN Ambient		
	VL	3.3 V	
Voltage	VN	3.8 V	
	VH	4.2 V	

NOTE: VL= lower extreme test voltage

VN= nominal voltage

VH= upper extreme test voltage

TN= normal temperature



4.3 Test Frequency

Took Mode	TX/RX	RF Channel				
Test Mode		Low (L)	Middle (M)	High (H)		
	TX	Channel 128	Channel 190	Channel 251		
GSM850	1.	824.2MHz	836.6MHz	848.8MHz		
GSIVIOSO	RX	Channel 128	Channel 190	Channel 251		
	IXX	869.2MHz	881.6MHz	893.8MHz		
	TX	Channel 4132	Channel 4182	Channel 4233		
WCDMA850	IX	826.4MHz	836.4MHz	846.6MHz		
WCDIVIA650	RX	Channel 4357	Channel 4407	Channel 4458		
		871.4MHz	881.4MHz	891.6MHz		
Test Mode	TX / RX	RF Channel				
Test Mode		Low (L)	Middle (M)	High (H)		
	TX	Channel 512	Channel 661	Channel 810		
GSM1900	IX	1850.2MHz	1880.0MHz	1909.8MHz		
G3W1900	DV	Channel 512	Channel 661	Channel 810		
	RX	1930.2 MHz	1960.0 MHz	1989.8 MHz		
	TX	Channel 9262	Channel9400	Channel9538		
WCDMA1900	17	1852.4MHz	1880.0MHz	1907.6MHz		
VVCDIVIA 1900	DV	Channel 9662	Channel 9800	Channel 9938		
	RX	1932.4 MHz	1960.0 MHz	1987.6 MHz		



4.4 DESCRIPTION OF TESTS

4.4.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-C-2004. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

Pd [dBm] = Pg [dBm] - cable loss [dB] + antenna gain [dBd/dBi]

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]).

Note: Reference test setup 3



4.4.2 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Note: Reference test setup 1.

4.4.3 Spurious and Harmonic Emissions at Antenna Terminal

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Note: Reference test setup 1.

4.4.4 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Note: Reference test setup 1.



4.4.5 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-C-2004. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

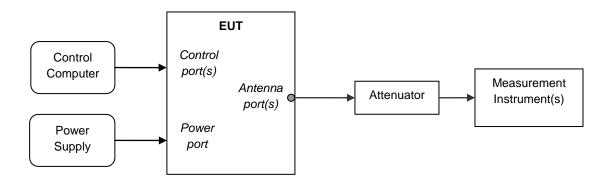
- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Note: Reference test setup 2.

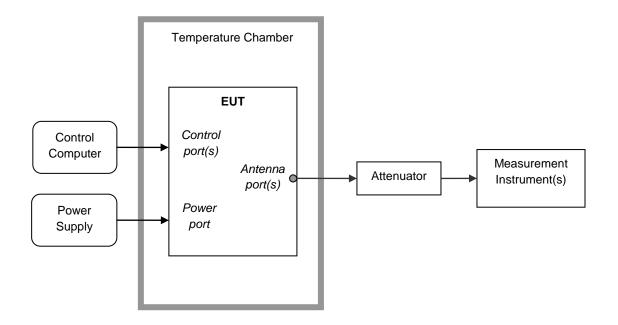


4.5 Test Setups

4.5.1 Test Setup 1



4.5.2 Test Setup 2

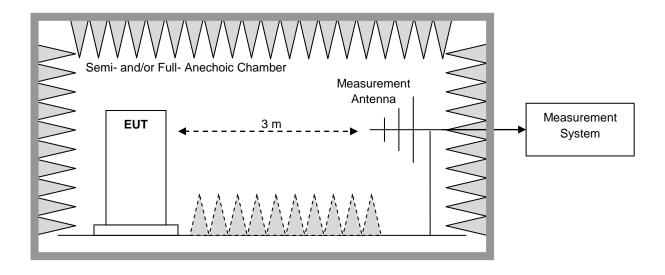




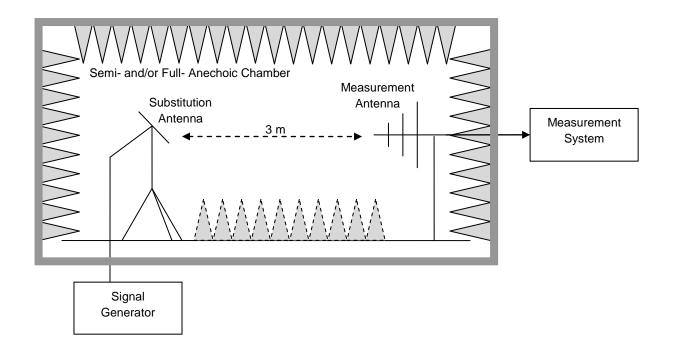
4.5.3 Test Setup 3

NOTE: Effective radiated power (ERP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

4.5.3.1 Step 1: Pre-test



4.5.3.2 Step 2: Substitution method to verify the maximum ERP





4.6 Test Conditions

Test Case		Test Condition	s	
Transmit	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
Output	Total	Test Setup	Test Seup 1	
Power Data		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
	Average Power,	Test Env.	Ambient Climate & Rated Voltage	
	Spectral Density	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
	Peak-to-Average	Test Env.	Ambient Climate & Rated Voltage	
	Ratio	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
Modulation Cl	Modulation Characteristics		Ambient Climate & Rated Voltage	
		Test Setup	Test Seup 1	
		RF Channels	M	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
Bandwidth	Occupied	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
	Emission	Test Env.	Ambient Climate & Rated Voltage	
	Bandwidth	Test Setup	Test Seup 1	
	(if required)	RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
Band Edges (Compliance	Test Env.	Ambient Climate & Rated Voltage	
		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
Spurious Emi	ssion at Antenna	Test Env.	Ambient Climate & Rated Voltage	
Terminals		Test Setup	Test Seup 1	
		RF Channels	L, M, H	
		(TX)	(L= low channel, M= middle channel, H= high channel)	



Test Case	Test Condition	s	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
Field Strength of Spurious	Test Env.	Ambient Climate & Rated Voltage	
Radiation	Test Setup	Test Seup 3	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1/TM2	
		NOTE: If applicable, the EUT conf. that has maximum power	
		density (based on the equivalent power level) is	
		selected.	
	RF Channels	L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel)	
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage;	
		(2) 85%, 100% and 115% of Rated Voltage at Ambient Climate.	
	Test Setup	Test Seup 2	
	RF Channels	L, M, H	
	(TX)	(L= low channel, M= middle channel, H= high channel)	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1	
	T est Env.	Ambient Temperature & Rated Voltage	
	Test Setup	Test Setup 3	
Bassiyar Spurious Emissions	Detector	QP,PK, AV	
Receiver Spurious Emissions	RF Channels	M	
	(TX)	M	
	Test Mode	GSM/TM1& GSM/TM2&UMTS/TM1	



5 <u>Main Test Instruments</u>

Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal. Due
Power supply	KEITHLEY	2303	1288003	2012-11-19	2014-11-18
Universal Radio Communication Tester	R&S	CMU200	123299	2012-09-20	2013-09-19
Spectrum Analyzer	Agilent	E4440A	MY48250119	2012-08-20	2013-08-19
Signal Analyzer	R&S	FSQ31	200021	2012-11-09	2013-11-08
Universal Radio Communication Tester	Agilent	E5515C	MY50260239	2012-11-09	2013-11-08
Temperature Chamber	WEISS	WKL64	5624600294001 0	2013-01-29	2014-01-28
Signal generator	Agilent	E8257D	MY49281095	2012-09-14	2013-09-13
Vector Signal Generator	R&S	SMU200A	104162	2012-10-16	2013-10-15
Spectrum analyzer	R&S	FSU3	200474	2013-01-29	2014-01-28
Spectrum analyzer	R&S	FSU43	100144	2013-01-29	2014-01-28
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2013-02-02	2014-02-01
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100391	2011-10-12	2013-10-11
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBE CK	VULB 9163	9163-521	2011-12-09	2013-12-08
Pyramidal Horn Antenna(18GHz-26.5 GHz)	ETS-Lindgren	3160-09	00091989	2011-10-20	2013-10-19



6 <u>Measurement Uncertainty</u>

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmit Output Power Data	Power [dBm]	U = 0.39 dB
Bandwidth	Magnitude [%]	U = 0.2%
Band Edge Compliance	Disturbance Power [dBm]	U = 2.0 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	U = 2.0 dB
Field Strength of Spurious Radiation	ERP [dBm]	For 3 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
		For 10 m Chamber:
		U = 4.6 dB (30 MHz to 1GHz)
		U = 3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy [ppm]	U = 0.21 ppm

END